Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/767,775	MILLER, KEVIN LEE
Examiner	Art Unit
Brian Young	2819

SEARCHED						
Cla	ss	Subclass	Date		Examiner	
34	1	144	2/17/2005		BY	
1		143			BY	
		155			BY	
		164			BY	
	1	67			BY	
	7	· 65			BY	
37	5	371			BY	
		372			BY	
		373			BY	
		377			BY	
		293			BY	
		294			BY	
37	0	505			BY	
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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